- **Phase-Lock Loop Clock Driver for Double Data-Rate Synchronous DRAM Applications**
- **Spread Spectrum Clock Compatible**
- **Operating Frequency: 60 MHz to 200 MHz**
- **Low Jitter (cycle-cycle): ±50 ps**
- **Low Static Phase Offset: ±50 ps**
- **Low Jitter (Period): ±35 ps**
- **Distributes One Differential Clock Input to 10 Differential Outputs**
- **Enters Low-Power Mode When No CLK Input Signal Is Applied or PWRDWN Is Low**
- **Operates From Dual 2.5-V Supplies**
- **Available in a 48-Pin TSSOP Package or 56-Ball MicroStar Junior™ BGA Package**
- **Consumes < 100-μA Quiescent Current**
- **External Feedback Pins (FBIN, $\overline{\text{FBIN}}$) Are Used to Synchronize the Outputs to the Input Clocks**
- **Meets/Exceeds the Latest DDR JEDEC Spec JESD82−1**

description

The CDCV857B is a high-performance, low-skew, low-jitter zero delay buffer that distributes a differential clock input pair (CLK, $\overline{\text{CLK}}$) to 10 differential pairs of clock outputs (Y[0:9], $\overline{\text{Y[0:9]}}$) and one differential pair of feedback clock outputs (FBOUT, $\overline{\text{FBOUT}}$). The clock outputs are controlled by the clock inputs (CLK, $\overline{\text{CLK}}$), the feedback clocks (FBIN, $\overline{\text{FBIN}}$), and the analog power input (AV_{DD}). When $\overline{\text{PWRDWN}}$ is high, theoutputs switch in phase and frequency with CLK. When $\overline{\text{PWRDWN}}$ is low, all outputs are disabled to a high-impedance state (3-state) and the PLL is shut down (low-power mode). The device also enters this low-power mode when the input frequency falls below a suggested detection frequency that is below 20 MHz (typical 10 MHz). An input frequency detection circuit detects the low frequency condition and, after applying a >20-MHz input signal, this detection circuit turns the PLL on and enables the outputs.

When AV_{DD} is strapped low, the PLL is turned off and bypassed for test purposes. The CDCV857B is also able to track spread spectrum clocking for reduced EMI.

Since the CDCV857B is based on PLL circuitry, it requires a stabilization time to achieve phase-lock of the PLL. This stabilization time is required following power up. The CDCV857B is characterized for both commercial and industrial temperature ranges.

AVAILABLE OPTIONS

T_A	TSSOP (DGG)	MicroStar Junior™ BGA (GQL)
0°C to 85°C	CDCV857BDGG	CDCV857BGQL
−40°C to 85°C	CDCV857BIGG	—

FUNCTION TABLE
(Select Functions)

INPUTS				OUTPUTS				PLL
AV_{DD}	$\overline{\text{PWRDWN}}$	CLK	$\overline{\text{CLK}}$	Y[0:9]	$\overline{\text{Y[0:9]}}$	FBOUT	$\overline{\text{FBOUT}}$	
GND	H	L	H	L	H	L	H	Bypassed/Off
GND	H	H	L	H	L	H	L	Bypassed/Off
X	L	L	H	Z	Z	Z	Z	Off
X	L	H	L	Z	Z	Z	Z	Off
2.5 V (nom)	H	L	H	L	H	L	H	On
2.5 V (nom)	H	H	L	H	L	H	L	On
2.5 V (nom)	X	<20 MHz	<20 MHz	Z	Z	Z	Z	Off

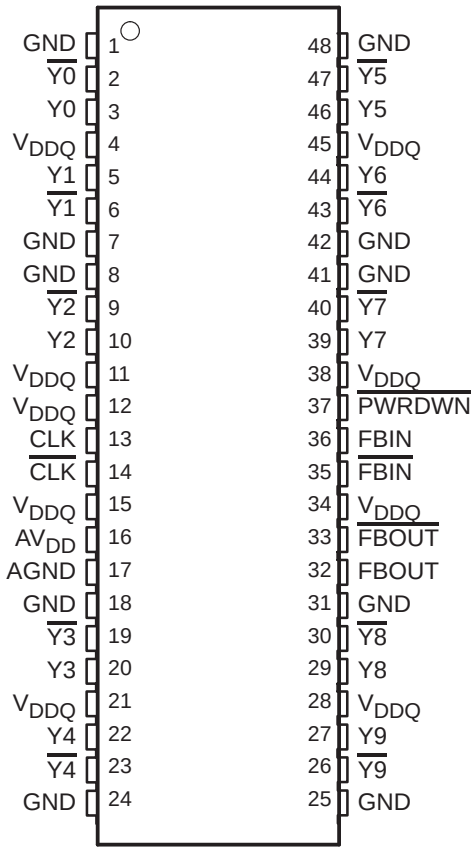
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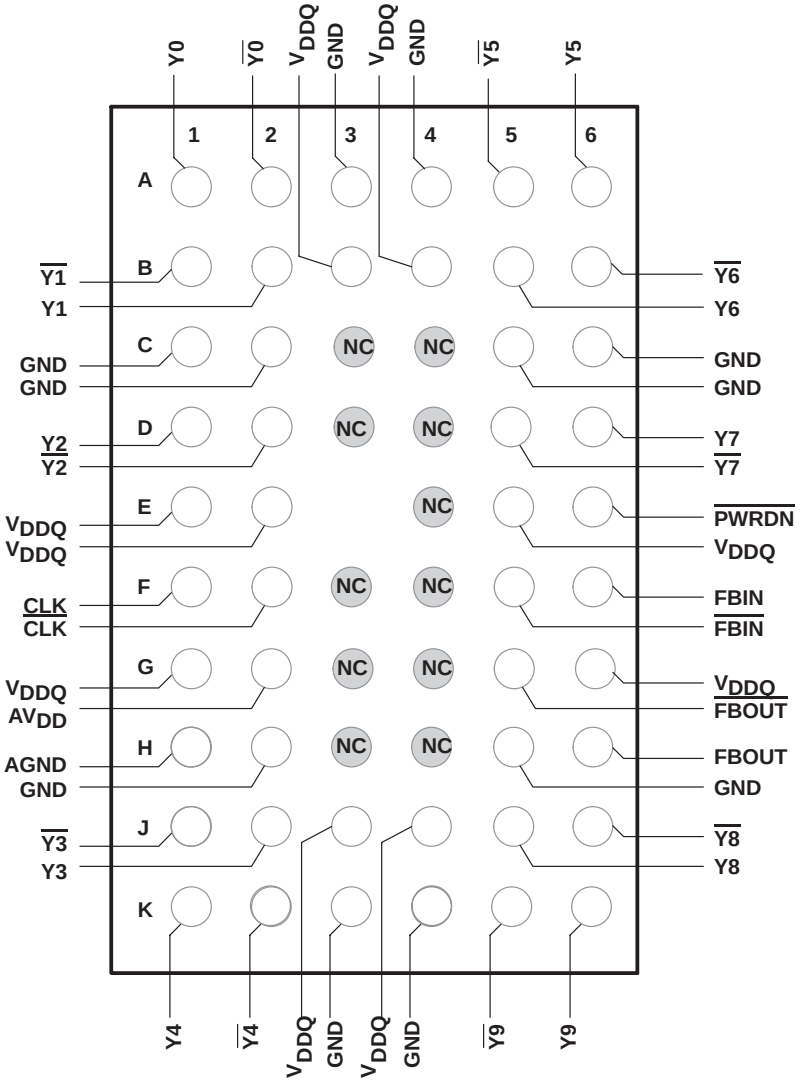
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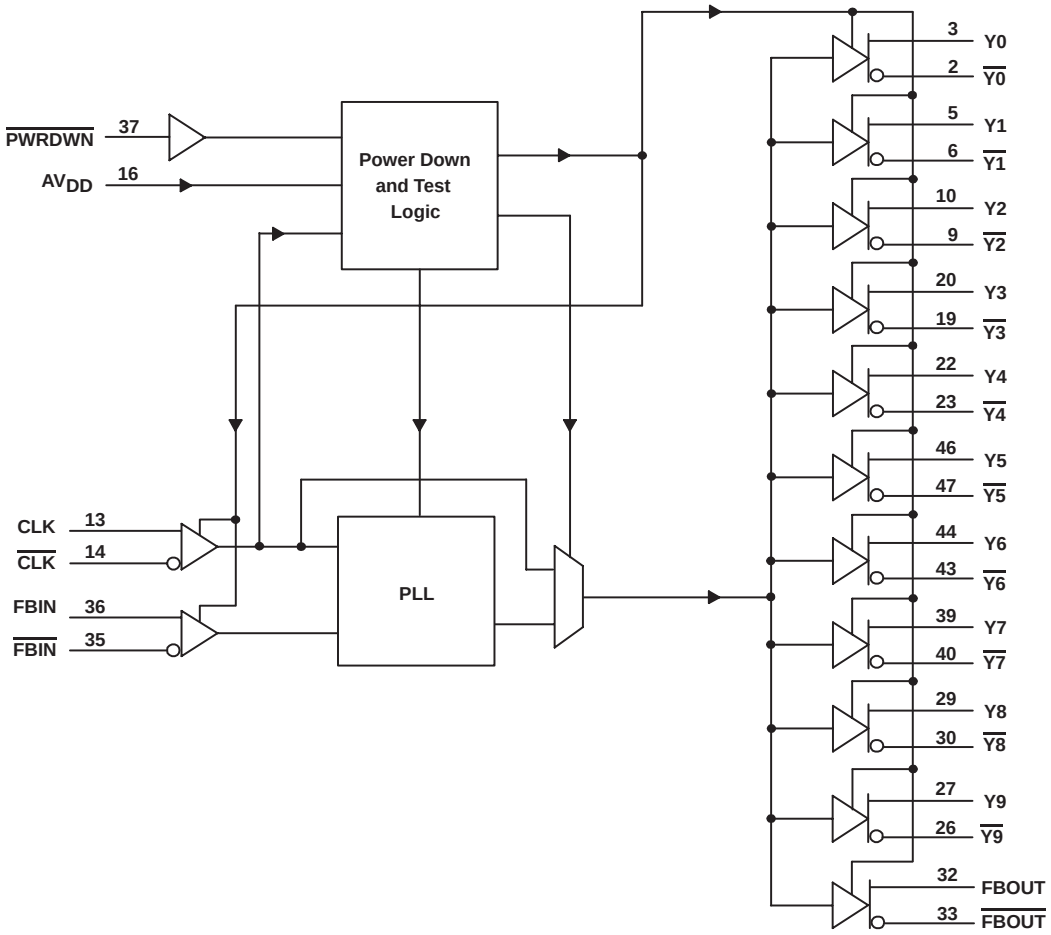
DGG PACKAGE
(TOP VIEW)



MicroStar Junior™ (GQL) Package
(TOP VIEW)



functional block diagram



Terminal Functions

TERMINAL NAME	TERMINAL DGG	TERMINAL GQL		DESCRIPTION
AGND	17	H1		Ground for 2.5-V analog supply
AV_{DD}	16	G2		2.5-V Analog supply
CLK, $\overline{CLK}$	13, 14	F1, F2	I	Differential clock input
$\overline{FBIN}$, FBIN	35, 36	F5, F6	I	Feedback differential clock input
FBOUT, $\overline{FBOUT}$	32, 33	H6, G5	O	Feedback differential clock output
GND	1, 7, 8, 18, 24, 25, 31, 41, 42, 48	A3, A4, C1, C2, C5, C6, H2, H5, K3, K4		Ground
$\overline{PWRDWN}$	37	E6	I	Output enable for Y and $\overline{Y}$
V_{DDQ}	4, 11, 12, 15, 21, 28, 34, 38, 45	B3, B4, E1, E2, E5, G1, G6, J3, J4		2.5-V Supply
Y[0:9]	3, 5, 10, 20, 22, 27, 29, 39, 44, 46	A1, B2, D1, J2, K1, A6, B5, D6, J5, K6	O	Buffered output copies of input clock, CLK
$\overline{Y[0:9]}$	2, 6, 9, 19, 23, 26, 30, 40, 43, 47	A2, B1, D2, J1, K2, A5, B6, D5, J6, K5	O	Buffered output copies of input clock, $\overline{CLK}$

absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V_{DDQ}, AV_{DD} . . . . . 0.5 V to 3.6 V
Input voltage range, V_I (see Notes 1 and 2) . . . . . –0.5 V to V_{DDQ} + 0.5 V
Output voltage range, V_O (see Notes 1 and 2) . . . . . –0.5 V to V_{DDQ} + 0.5 V
Input clamp current, I_{IK} (V_I < 0 or V_I > V_{DDQ}) . . . . . ±50 mA
Output clamp current, I_{OK} (V_O < 0 or V_O > V_{DDQ}) . . . . . ±50 mA
Continuous output current, I_O (V_O = 0 to V_{DDQ}) . . . . . ±50 mA
Continuous current to GND or V_{DDQ} . . . . . ±100 mA
Package thermal impedance, θ_{JA} (see Note 3): GQL package . . . . . 137.6°C/W
Storage temperature range T_{stg} . . . . . –65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
2. This value is limited to 3.6 V maximum.
3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

			MIN	TYP	MAX	UNIT
Supply voltage		V_{DDQ}	2.3		2.7	V
		AV_{DD}	V_{DDQ} − 0.12		2.7	V
Low-level input voltage, V_{IL}	CLK, $\overline{CLK}$, FBIN, $\overline{FBIN}$				$V_{DDQ}/2$ – 0.18	V
	$\overline{PWRDWN}$		−0.3		0.7	
High-level input voltage, V_{IH}	CLK, $\overline{CLK}$, FBIN, $\overline{FBIN}$		$V_{DDQ}/2$ + 0.18			V
	$\overline{PWRDWN}$		1.7		V_{DDQ} + 0.3	
DC input signal voltage (see Note 5)			–0.3		V_{DDQ} + 0.3	V
Differential input signal voltage, V_{ID} (see Note 6)	dc	CLK, FBIN	0.36		V_{DDQ} + 0.6	V
	ac	CLK, FBIN	0.7		V_{DDQ} + 0.6	
Input differential pair cross voltage, V_{IX} (see Note 7)			$V_{DDQ}/2$ – 0.2		$V_{DDQ}/2$ + 0.2	V
High-level output current, I_{OH}					−12	mA
Low-level output current, I_{OL}					12	mA
Input slew rate, SR			1		4	V/ns
Operating free-air temperature, T_A		Commercial	0		85	°C
		Industrial	−40		85	

NOTES: 4. The unused inputs must be held high or low to prevent them from floating.
5. The dc input signal voltage specifies the allowable dc execution of the differential input.
6. The differential input signal voltage specifies the differential voltage |VTR − VCP| required for switching, where VTR is the true input level and VCP is the complementary input level.
7. The differential cross-point voltage is expected to track variations of V_{CC} and is the voltage at which the differential signals must be crossing.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V_{IK}	Input voltage	All inputs	V_{DDQ} = 2.3 V, I_I = –18 mA			–1.2	V
V_{OH}	High-level output voltage		V_{DDQ} = min to max, I_{OH} = –1 mA	V_{DDQ} – 0.1			V
			V_{DDQ} = 2.3 V, I_{OH} = –12 mA	1.7			
V_{OL}	Low-level output voltage		V_{DDQ} = min to max, I_{OL} = 1 mA			0.1	V
			V_{DDQ} = 2.3 V, I_{OL} = 12 mA			0.6	
V_{OD}	Output voltage swing‡		Differential outputs are terminated with 120 Ω /CL = 14 pF (See Figure 3)	1.1		V_{DDQ} – 0.4	V
V_{OX}	Output differential cross-voltage§			$V_{DDQ}/2$ – 0.15	$V_{DDQ}/2$	$V_{DDQ}/2$ + 0.15	
I_I	Input current		V_{DDQ} = 2.7 V, V_I = 0 V to 2.7 V			±10	µA
I_{OZ}	High-impedance state output current		V_{DDQ} = 2.7 V, V_O= V_{DDQ} or GND			±10	µA
I_{DDPD}	Power-down current on V_{DDQ} + AV_{DD}		CLK and $\overline{CLK}$ = 0 MHz; $\overline{PWRDWN}$ = Low; Σ of I_{DD} and AI_{DD}		20	100	µA
AI_{DD}	Supply current on AV_{DD}		f_O = 170 MHz		7	10	mA
			f_O = 200 MHz		9	12	
C_I	Input capacitance		V_{DDQ} = 2.5 V, V_I = V_{DDQ} or GND	2	2.5	3.5	pF

† All typical values are at a respective nominal V_{DDQ}.
‡ The differential output signal voltage specifies the differential voltage |VTR − VCP|, where VTR is the true output level and VCP is the complementary output level.
§ The differential cross-point voltage is expected to track variations of V_{DDQ} and is the voltage at which the differential signals must be crossing. The frequency range is 100 MHz to 200 MHz.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
I_{DD}	Dynamic current on V_{DDQ}	Without load	f_O = 170 MHz		100	110	mA
			f_O = 200 MHz		105	120	
		Differential outputs terminated with 120 Ω/CL = 0 pF	f_O = 170 MHz		200	240	
			f_O = 200 MHz		210	250	
		Differential outputs terminated with 120 Ω/CL = 14 pF	f_O = 170 MHz		260	300	
			f_O = 200 MHz		280	320	
ΔC	Part-to-part input capacitance variation	V_{DDQ} = 2.5 V, V_I = V_{DDQ} or GND				1	pF
$C_{I(\Delta)}$	Input capacitance difference between CLK and CLKB, FBIN, and FBINB	V_{DDQ} = 2.5 V, V_I = V_{DDQ} or GND				0.25	pF
C_O	Output capacitance	V_{DDQ} = 2.5 V, V_O = V_{DDQ} or GND		2.5	3	3.5	pF

† All typical values are at a respective nominal V_{DDQ}.

timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN	MAX	UNIT
f_{CLK}	Operating clock frequency	60	200	MHz
	Application clock frequency			
	Input clock duty cycle	40%	60%	
	Stabilization time† (PLL mode)		10	µs
	Stabilization time‡ (Bypass mode)		30	ns

† The time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. For phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK and V_{DD} must be applied. Until phase lock is obtained, the specifications for propagation delay, skew, and jitter parameters given in the switching characteristics table are not applicable. This parameter does not apply for input modulation under SSC application.

‡ A recovery time is required when the device goes from power-down mode into bypass mode (AVDD at GND).

switching characteristics

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}§	Low to high level propagation delay time	Test mode/CLK to any output		3.5		ns
t_{PHL}§	High-to low level propagation delay time	Test mode/CLK to any output		3.5		ns
$t_{jit(per)}$¶	Jitter (period), See Figure 7	66 MHz	−60		60	ps
		100/133/167/200 MHz	−35		35	ps
$t_{jit(cc)}$¶	Jitter (cycle-to-cycle), See Figure 4	66 MHz	−75		75	ps
		100/133/167/200 MHz	−50		50	
$t_{jit(hper)}$¶	Half-period jitter, See Figure 8	66 MHz	−100		100	ps
		100/133/167/200 MHz	−75		75	
$t_{slr(o)}$	Output clock slew rate, See Figure 9	Load: 120 Ω/14 pF	1		2	V/ns
$t_{(Ø)}$	Static phase offset, See Figure 5	66 MHz	–100		100	ps
		100/133/167/200 MHz	–50		50	
$tsk_{(o)}$	Output skew, See Figure 6	Load: 120 Ω/14 pF		70	100	ps
t_r, t_f	Output rise and fall times (20% − 80%)	Load: 120 Ω/14 pF	600		900	ps

§ Refers to the transition of the noninverting output.

¶ This parameter is assured by design but can not be 100% production tested.

PARAMETER MEASUREMENT INFORMATION

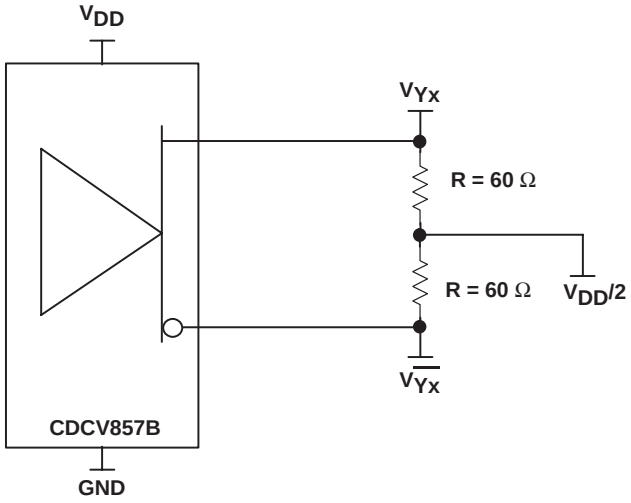


Figure 1. IBIS Model Output Load

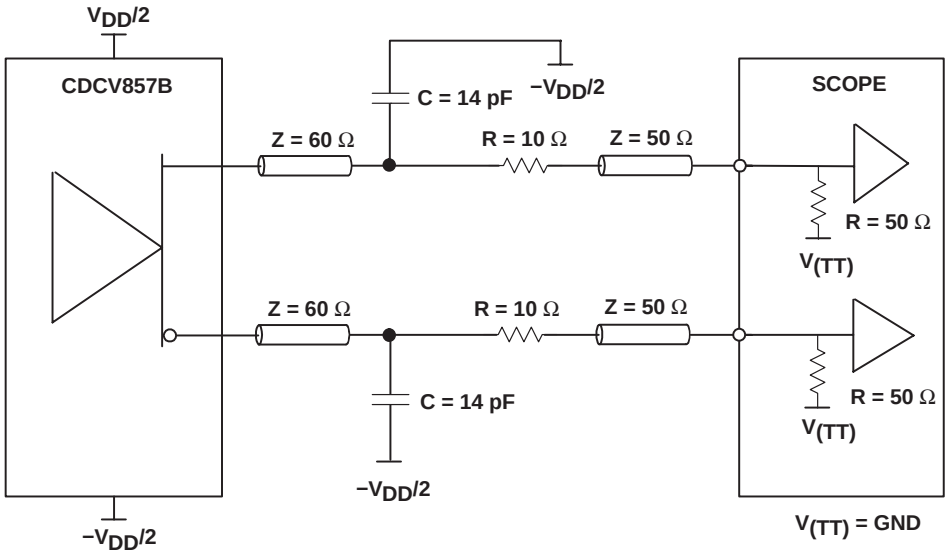


Figure 2. Output Load Test Circuit

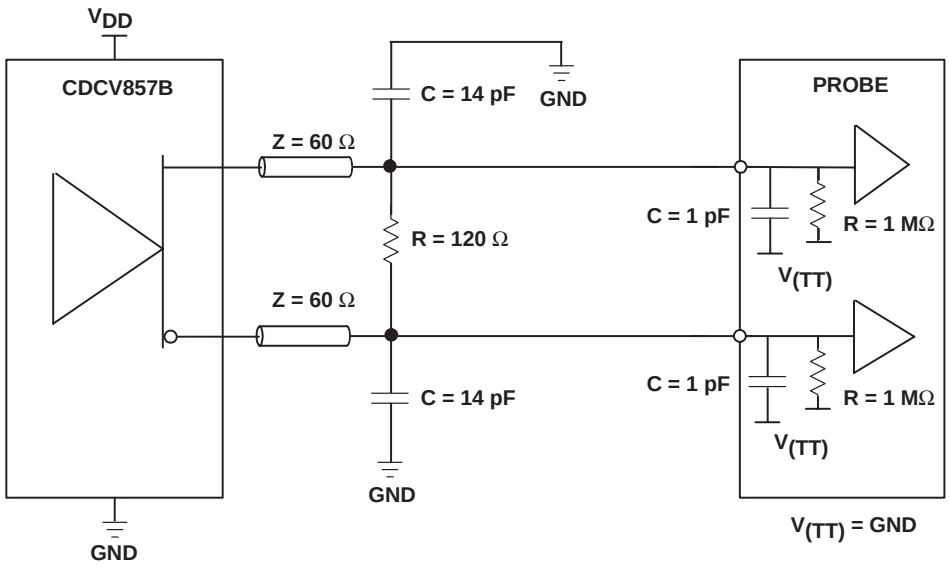
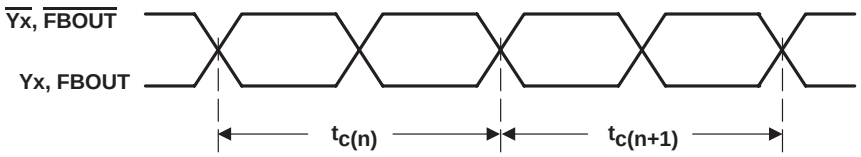


Figure 3. Output Load Test Circuit for Crossing Point



$$t_{jit(cc)} = t_{c(n)} - t_{c(n+1)}$$

Figure 4. Cycle-to-Cycle Jitter

PARAMETER MEASUREMENT INFORMATION

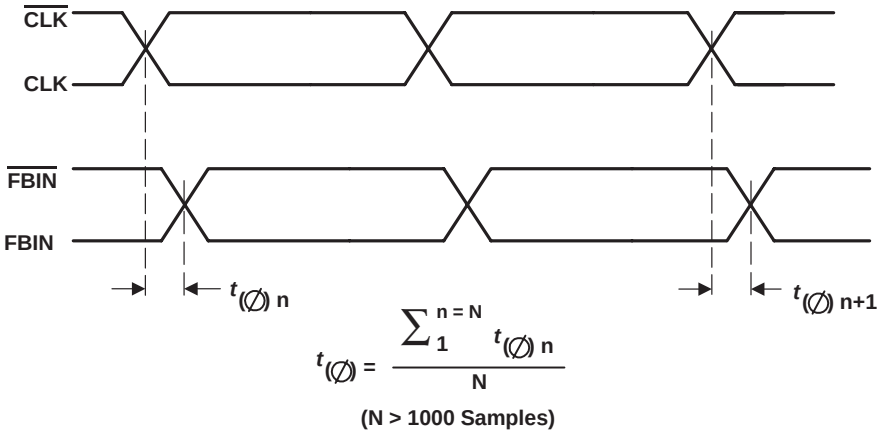


Figure 5. Phase Offset

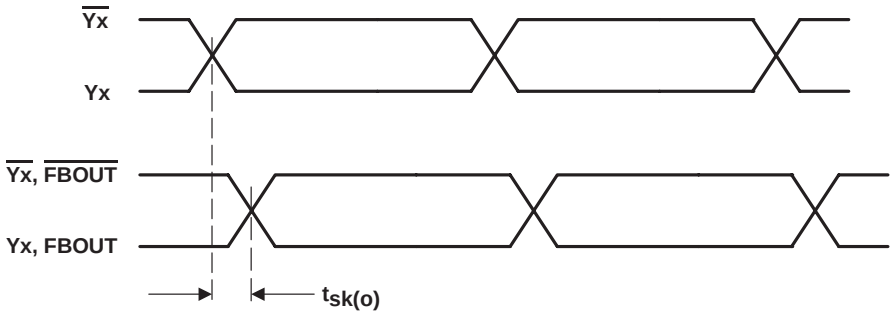
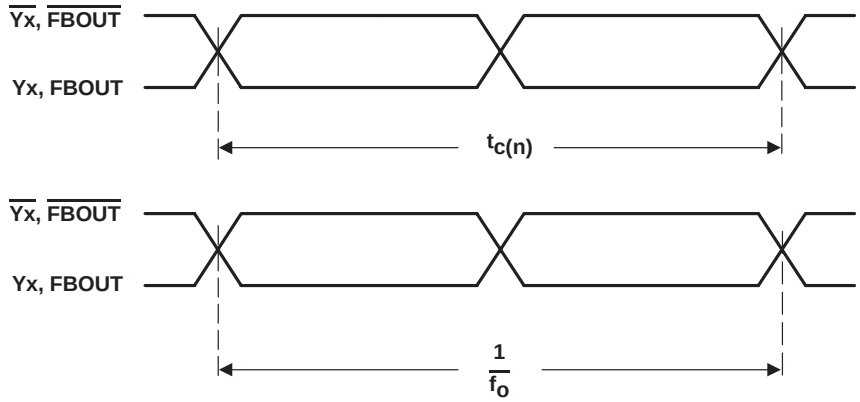


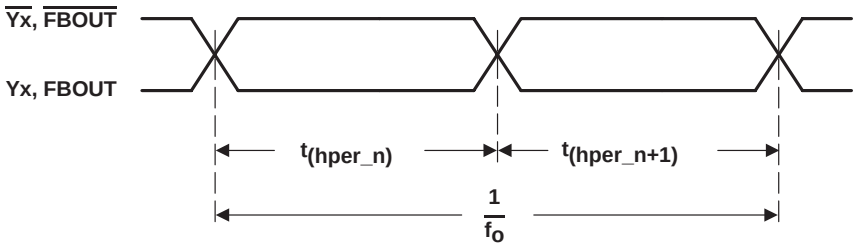
Figure 6. Output Skew

PARAMETER MEASUREMENT INFORMATION



$t_{jit(per)} = t_{cn} - \frac{1}{f_o}$ f_O = Average input frequency measured at CLK/$\overline{CLK}$

Figure 7. Period Jitter



$t_{jit(hper)} = t_{(hper_n)} - \frac{1}{2xf_o}$

n = any half cycle

f_O = Average input frequency measured at CLK/$\overline{CLK}$

Figure 8. Half-Period Jitter



$t_{slr(I/O)} = \frac{V_{80\%} - V_{20\%}}{t_{r(I/O)}}$ $t_{slf(I/O)} = \frac{V_{80\%} - V_{20\%}}{t_{f(I/O)}}$

Figure 9. Input and Output Slew Rates

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
CDCV857BDGG	ACTIVE	TSSOP	DGG	48	40	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CDCV857BDGGR	ACTIVE	TSSOP	DGG	48	2000	None	Call TI	Call TI
CDCV857BGQLR	ACTIVE	VFBGA	GQL	56	1000	None	Call TI	Level-2A-220C-4 WKS
CDCV857BIDGG	ACTIVE	TSSOP	DGG	48	40	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CDCV857BIDGGR	ACTIVE	TSSOP	DGG	48	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

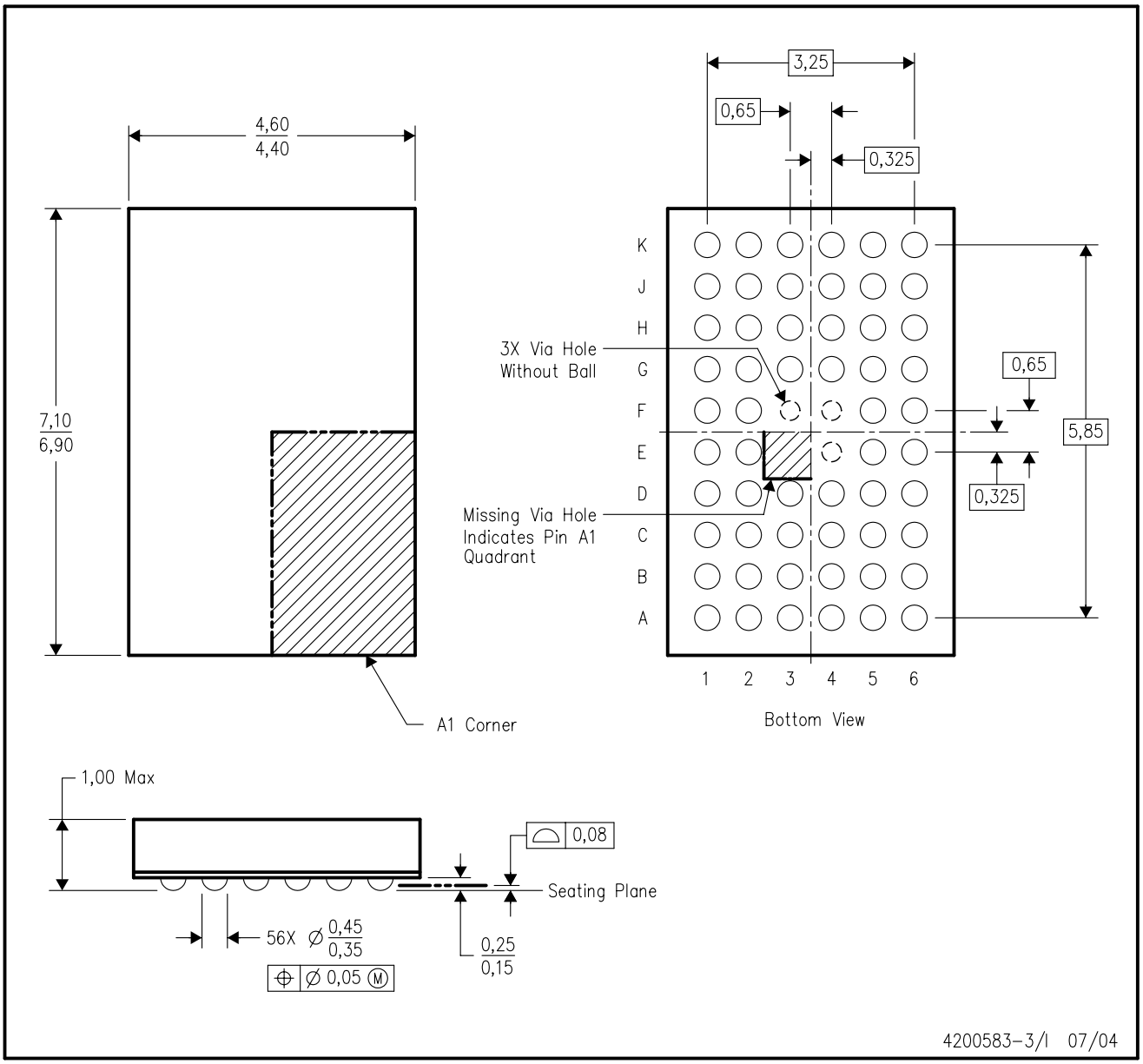
(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
None: Not yet available Lead (Pb-Free).
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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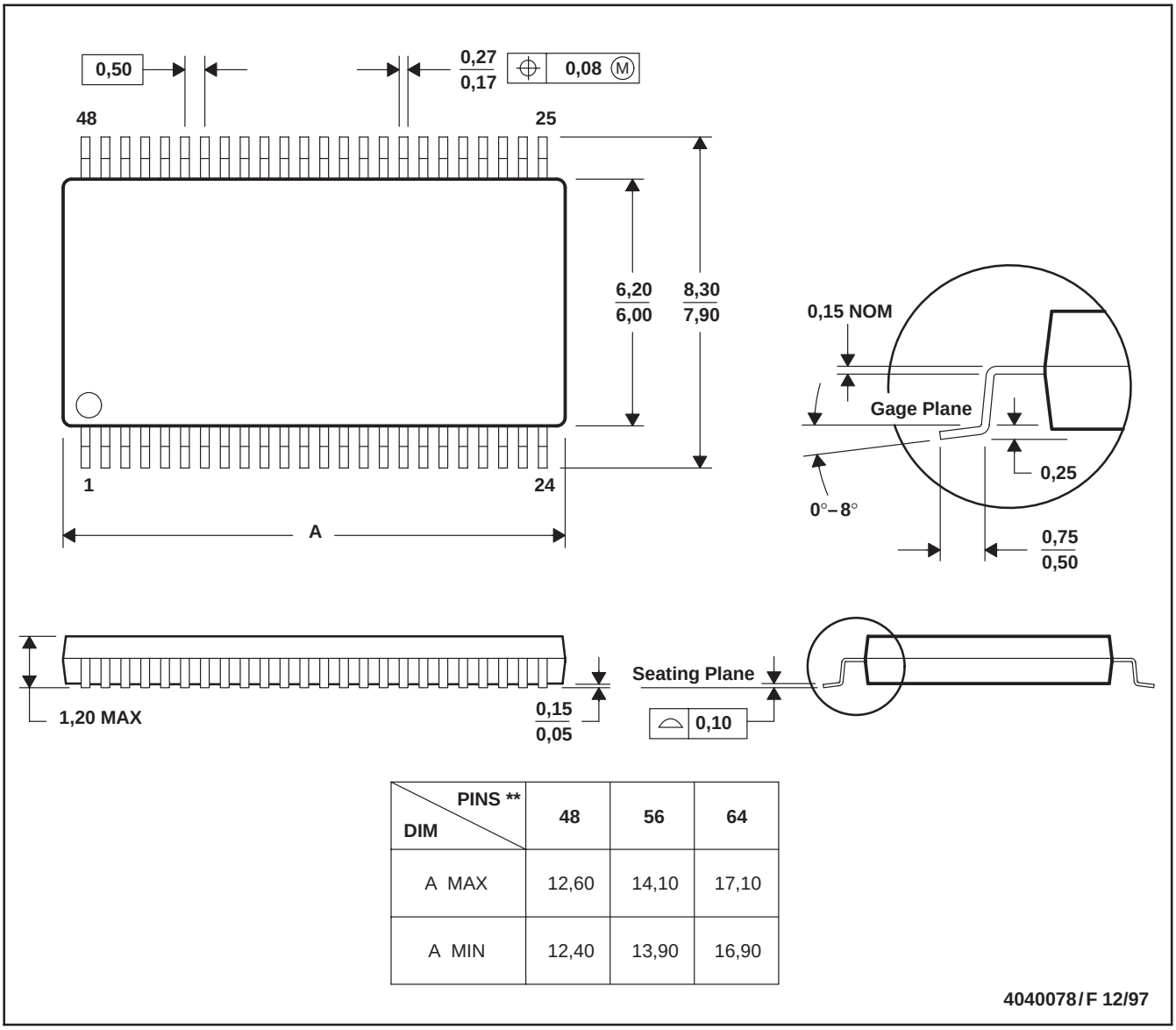
GQL (R–PBGA–N56) PLASTIC BALL GRID ARRAY



NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Falls within JEDEC MO–225 variation BA.
D. This package is tin–lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead–free.

DGG (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

48 PINS SHOWN



DIM \ PINS **	48	56	64
A MAX	12,60	14,10	17,10
A MIN	12,40	13,90	16,90

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «**JONHON**», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «**FORSTAR**».

AVIC JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).

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